Erratum: “A procedure to determine the optimum imaging parameters for atomic/molecular resolution frequency modulation atomic force microscopy” [Rev. Sci. Instrum. 81, 093701 (2010)]

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Equation (2) in the original article1 was incorrect. The correct equation should read

$$\delta f (k, A) = \sqrt{\frac{f_0 k B}{\pi kQA^2} + \frac{2n_d^2 B^3}{3A^2}}.$$  \hspace{1cm} (2)

This correction does not affect any other contents of the original article.


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